

Notice of References Cited	Application/Control No. 10/694,089	Applicant(s)/Patent Under Reexamination OMIYA ET AL.	
	Examiner Nelson D. Hernandez	Art Unit 2622	Page 1 of 1

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*	B	US-4,937,609	06-1990	Wakabayashi et al.	396/73
*	C	US-4,482,228	11-1984	Fujita, Susumu	396/73
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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